# SHIPLEY

MICROPOSIT S1800 SERIES PHOTO RESISTS are positive photoresist systems engineered to satisfy the microelectronics industry's requirements for advanced IC device fabrication. The system has been engineered using a toxicologically safer alternative casting solvent to the ethylene glycol derived ether acetates. The dyed photoresist versions are recommended to minimize notching and maintain linewidth control when processing on highly reflective substrates.

## MICROPOSIT S1800 SERIES PHOTO RESISTS FEATURE:

#### **Product Assurance**

- Lot-to-lot consistency through state-of-the-art physical, chemical and functional testing
- Filtered to 0.2 µm absolute

#### **Coating Properties**

- <sup>1</sup>Cellosolve<sup>®</sup> Acetate and xylene free
- Striation-free coatings
- Excellent adhesion
- Excellent coating uniformity
- A variety of standard viscosities are available for single-layer processing

#### **Exposure Properties**

- Optimized for G-Line exposure
- Effective for broad-band exposure
- Reflective notch and linewidth control using dyed versions

#### **Develop Properties**

- Optimized for use with the MICROPOSIT<sup>®</sup> MF<sup>®</sup>-319 Metal-lon-Free DEVELOPER family
- Compatible with Metal-Ion-Bearing MICROPOSIT DEVELOPERS

#### **Removal Property**

 Residue-free photoresist removal using standard MICROPOSIT REMOVERS

High Resolution Process Parameters		
(Refer to Figure 1)		
Substrate:	Polysilicon	
Photoresist:	MICROPOSIT <sup>®</sup> S1813 <sup>®</sup> PHOTO RESIST	
Coat:	12,300Å	
Softbake:	115°C/60 sec. Hotplate	
Exposure:	Nikon 1505 G6E, G-Line (0.54 NA), 150 mJ/cm <sup>2</sup>	
Develop:	MICROPOSIT <sup>®</sup> MF <sup>®</sup> -321 DEVELOPER	
15 + 50 sec. Double Spray Puddle (DSP) @ 21°C		

<sup>1</sup>Registered trademark of Union Carbide Corporation

### MICROPOSIT<sup>®</sup> S1800<sup>®</sup> SERIES PHOTO RESISTS



0.80 µm Lines/Spaces



0.70 µm Lines/Spaces



0.60 µm Lines/Spaces



0.50 µm Lines/Spaces



0.48 µm Lines/Spaces

Masking Linearity SEMS Figure 1.

#### Instructions for Use

The following instructions cover the use of MICROPOSIT S1800 SERIES PHOTO RESISTS for all levels of microelectronic device fabrication. Exact process parameters are application and equipment dependent.

#### **Substrate Preparation**

MICROPOSIT S1800 SERIES PHOTO RESISTS hexamethyldisilazane well with work the based MICROPOSIT PRIMERS. Concentrated MICROPOSIT PRIMER is recommended when vacuum vapor priming. Diluted PRIMER is recommended for liquid phase priming applications.

#### Coat

MICROPOSIT S1800 SERIES PHOTO RESISTS provide uniform defect-free coatings over a wide range of film thicknesses. The film thickness versus spin speed plots displayed in Figures 1 and 2 provide information required to the properly select a MICROPOSIT S1800 PHOTO RESIST version to meet process dependent thickness specifications. Maximum coating uniformity is typically attained between the spin speeds of 3500 rpm and 5500 rpm.

Process Parameters			
(Refer to Figures 1 and 2)			
Substrate	Silicon .		
Coat	SVG 81		
Softbake	115°C/60 seconds Hotplate		
Measure Nanometrics 210			

The dispersion curve and Cauchy equation displayed in **Figure 3** describe how the refractive index of the photoresist film varies as a function of the wavelength of light incident upon the film. This information is required to program ellipsometric and other optically based photoresist measuring equipment.

Process Parameters (Refer to Figure 3)			
Substrate	Silicon		
Coat	13,675Å		
Softbake	115°C/60 seconds Hotplate		
Measure	Prometrix SM300		

#### MICROPOSIT S1800 PHOTO RESIST UNDYED SERIES Figure 1. Spin Speed Curves



#### MICROPOSIT S1800 PHOTO RESIST DYED SERIES Figure 2. Spin Speed Curves



MICROPOSIT<sup>®</sup> S1813<sup>®</sup> PHOTO RESIST Figure 3. Dispersion Curve



#### Exposure

Proper film thickness selection is critical in order to reduce photospeed and critical dimension variability. The interference curves displayed in **Figure 4** illustrate the photospeed variability as a function of film thickness. Dyed versions suppress the interference effects which are more pronounced when exposing with monochromatic light sources and when using reflective substrates.

Process Parameters (Refer to Figure 4)		
Substrate	Silicon	
Coat	GCA 1006 <sup>2</sup> WAFERTRAC <sup>®</sup>	
Softbake	115°C/60 seconds Hotplate	
Expose	GCA 8500 G-Line (0.35 NA)	
Developer	MF-321 /10 + 30 DSP @ 21°C	

MICROPOSIT S1800 SERIES PHOTO RESISTS can be exposed with light sources in the spectral output range of 350 nm -450 nm. The exposure properties have been optimized for use at 436 nm. **Figures 5 and 6** show the absorbance spectrums for MICROPOSIT S1813 and S1813 J2<sup>®</sup> PHOTO RESISTS.

Process Parameters (Refer to Figures 5 and 6)		
Substrate	Quartz	
Coat	12,300Å	
Softbake	115°C/60 seconds Hotplate	
Expose	Oriel Scanning Wedge	
Measure	Hewlett Packard 8450A	
Spectrophotometer		

Table 1summarizestheDillparametersforeachMICROPOSITS1800SERIESPHOTORESISTversion.sion.Dillparametersareusedinopticalexposuremodelssuch asSAMPLEandPROLITH.

MICROPOSIT S1800 SERIES PHOTO RESISTS			
Table 1. Dill Parameters			

	365 nm		436 nm	
Photoresist	А	В	Α	В
	(µm⁻¹)	(µm⁻¹)	(µm <sup>-1</sup> )	(µm⁻¹)
S1813	1.07	0.31	0.61	0.08
S1813 D1	1.05	0.34	0.58	0.26
S1811 J2	1.07	0.49	0.59	0.61
S1818 J1	1.06	0.42	0.57	0.37

<sup>2</sup> Registered Trademark of GCA, a unit of General Signal

MICROPOSIT S1813 and S1813 J2 PHOTO RESISTS Figure 4. Interference Curves



MICROPOSIT S1813 PHOTO RESIST Figure 5. Absorbance Spectrum



MICROPOSIT S1813 J2 PHOTO RESIST Figure 6. Absorbance Spectrum



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**Figure 7** displays a contrast curve for MICROPOSIT S1813 PHOTO RESIST developed with MICROPOSIT<sup>®</sup> MF<sup>®</sup>-321 DEVELOPER. In general, high contrast values correlate to higher angle wall profiles.

Process Parameters (Refer to Figure 7)		
Substrate	Silicon	
Coat	12,300Å	
Softbake	Softbake 115°C/60 seconds Hotplate	
Expose	GCA 8500 G-Line (0.35 NA)	
Develop	MF-321 /10 + 30 DSP @ 21°C	

#### DEVELOP

MICROPOSIT S1800 SERIES PHOTO RESISTS are compatible with both Metal-Ion-Free (MIF) and Metal-Ion-Bearing (MIB) developers. A photoresist and developer system is dependent upon specific application requirements. Contact your local Shipley Technical Sales Representative for additional product information.

Figures 8 thru 10 illustrate the lithographic functionality of MICROPOSIT S1813 PHOTO RESIST using process parameters designed to maximize resolution while maintaining excellent exposure and focus latitude (refer to SEM photographs in **Figure 1**). The functional lithographic responses are summarized in **Table 2**.

Process Parameters (Refer to Figures 8 thru 10)		
Substrate	Silicon	
Coat	12,300Å	
Softbake	115°C/60 seconds Hotplate	
Expose	Nikon 1505 G6E G-Line (0.54 NA)	
Develop	MF-321 /15 + 50 DSP @ 21°C	

#### MICROPOSIT S1813 PHOTO RESIST with MICROPOSIT MF-321 DEVELOPER Table 2. Functional Lithographic Summary Data

Sizing Energy	150 mJ/cm <sup>2</sup> (1.3 E <sub>0</sub> )		
Resolution	0.48 µm		
Masking Linearity (±10% CD)	0.50 µm		
	1.0µm L/S	0.60 µm L/S	
Exposure Latitude (±10% CD)	65%	45%	
Focus Latitude (±10% CD)	2.25 µm	1.25 µm	
≥ 85° Wall Angle			











**MICROPOSIT S1813 PHOTO RESIST** 

#### **Handling Precautions**

WARNING: MICROPOSIT S1800 SERIES PHOTO RESISTS are combustible mixtures containing propylene glycol monomethyl ether acetate. Contact with eyes, skin and mucous membranes causes irritation. Handle with care. Do not get in eyes, on skin or on clothing. Avoid breathing vapors or mists. Use with adequate ventilation. Wash thoroughly after handling.

Wear chemical goggles, chemical gloves and suitable protective clothing when handling MICROPOSIT S1800 SERIES PHOTO RESISTS.

In case of eye or skin contact, flush affected areas with plenty of water for at least 15 minutes. Then contact a physician at once.

Consult product Material Safety Data Sheet before using.

#### **Toxicological and Health Advantages**

The solvent used in MICROPOSIT S1800 SERIES PHOTO RESISTS is propylene glycol monomethyl ether acetate. Toxicological studies reported that propylene glycol derivatives contained in MICROPOSIT S1800 SERIES PHOTO RESISTS do **not** demonstrate the adverse blood effects and reproductive effects that ethylene glycol derived ether acetates demonstrate (NIOSH Current Intelligence Bulletin 9 -5/2/83).

#### Storage

Store MICROPOSIT S1800 PHOTO RESISTS only in upright, original containers in a dry area at 50°-70°F (10°-21°C). Store away from light, oxidants, heat, and sources of ignition. Do not store in sunlight. Keep container sealed when not in use.

#### Equipment

MICROPOSIT S1800 SERIES PHOTO RESISTS are compatible with most commercially available photoresist processing equipment. Compatible materials include stainless steel, glass, ceramic, unfilled polypropylene, high density polyethylene, polytetrafluoroethylene, or equivalent materials.

#### **Technical Literature**

Please contact your Shipley Technical Sales Representative for information on the use and performance of Shipley products.



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